Applicant(s)/Patent Under Reexamination SHAKED ET AL. Application/Control No. 09/877,516 Notice of References Cited Examiner Art Unit Page 1 of 1

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EDWYN LABAZE **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	ŲS-5,726,435	03-1998	Hara et al.	235/494
	В	US-6,000,614	12-1999	Yang et al.	235/460
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	H.	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	บูร-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	672 994	03-1995	EP	Nojiri, Tadao	
	0					
	Р					
	. Q					
	R					
	s					
,	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.